

### FEATURES

- Double Side Cooling
- High Surge Capability
- Very Low Cosmic Ray FIT Rating
- High dV/dt Rating

### APPLICATIONS

- Multi-level VSC Bypass thyristor for HVDC

### VOLTAGE RATINGS

Part and Ordering Number	Repetitive Peak Voltages $V_{DRM}$ and $V_{RRM}$ (V)	Conditions
ACR3200VR33	1000 / 3300	$T_{vj} = -40^{\circ}\text{C}$ to $125^{\circ}\text{C}$ , $I_{DRM} = I_{RRM} = 400\text{mA}$ , $V_{DRM}, V_{RRM} t_p = 10\text{ms}$

### ORDERING INFORMATION

When ordering, select the required part number shown in the Voltage Ratings selection table.

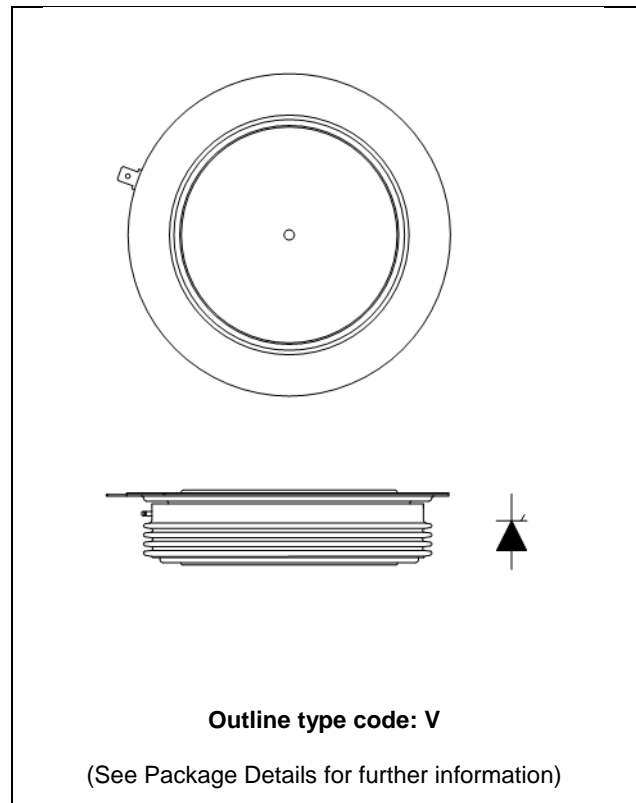
For example:

**ACR3200VR33**

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

### KEY PARAMETERS

$V_{DRM}$	<b>1000V</b>
$V_{DRM}$	<b>3300V</b>
$I_{T(AV)}$	<b>3200A</b>
$I_{TSM}$	<b>43000A</b>
dV/dt	<b>10kV/μs</b>
dI/dt	<b>400A/μs</b>



**Fig. 1 Package outline**

## CURRENT RATINGS

$T_{case} = 60^{\circ}C$  unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
<b>Double Side Cooled</b>				
$I_{T(AV)}$	Mean on-state current	Half wave resistive load	3200	A
$I_{T(RMS)}$	RMS value	-	5030	A
$I_r$	Continuous (direct) on-state current	-	4900	A

## SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
$I_{TSM}$	Surge (non-repetitive) on-state current	10ms half sine, $T_{case} = 125^{\circ}C$	43	kA
$I^2t$	$I^2t$ for fusing	$V_R = 0$	9.24	MA <sup>2</sup> s

## THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions	Min.	Max.	Units	
$R_{th(j-c)}$	Thermal resistance - junction to case	Double side cooled	DC	-	0.00746	$^{\circ}C/W$
		Single side cooled	Anode DC	-	0.0130	$^{\circ}C/W$
			Cathode DC	-	0.0178	$^{\circ}C/W$
$R_{th(c-h)}$	Thermal resistance - case to heatsink	Clamping force 54kN	Double side	-	0.002	$^{\circ}C/W$
		(with mounting compound)	Single side	-	0.004	$^{\circ}C/W$
$T_{vj}$	Virtual junction temperature	Blocking $V_{DRM} / V_{RRM}$	-	125	$^{\circ}C$	
$T_{stg}$	Storage temperature range		-55	125	$^{\circ}C$	
$F_m$	Clamping force		48	59	kN	

**DYNAMIC CHARACTERISTICS**

Symbol	Parameter	Test Conditions		Min.	Max.	Units
<b>I<sub>RRM</sub>/I<sub>DRM</sub></b>	Peak reverse and off-state current	At V <sub>RRM</sub> /V <sub>DRM</sub> , T <sub>case</sub> = 125°C		-	400	mA
<b>dV/dt</b>	Max. linear rate of rise of off-state voltage	To 67% V <sub>DRM</sub> , T <sub>j</sub> = 60°C, gate open		-	10000	V/μs
<b>dI/dt</b>	Rate of rise of on-state current	From 67% V <sub>DRM</sub> to 2x I <sub>T(AV)</sub> Gate source 30V, 10Ω tr < 0.5μs, T <sub>j</sub> = 125°C	Non-repetitive	-	400	A/μs
<b>V<sub>T(RO)</sub></b>	Threshold voltage - Low level	300A to 2300A at T <sub>case</sub> = 125°C		-	0.83	V
	Threshold voltage - High level	2300A to 8000A at T <sub>case</sub> = 125°C		-	1.04	V
<b>r<sub>T</sub></b>	On-state slope resistance - low level	300A to 2300A at T <sub>case</sub> = 125°C		-	0.24	mΩ
	On-state slope resistance - High level	2300A to 8000A at T <sub>case</sub> = 125°C		-	0.15	mΩ
<b>t<sub>gd</sub></b>	Delay time	V <sub>D</sub> = 67% V <sub>DRM</sub> , I <sub>g</sub> = 3A tr = 0.5μs, T <sub>j</sub> = 25°C, tp = 40μs		-	3	μs
<b>V<sub>pu</sub></b>	Pick-up Voltage	I <sub>g</sub> = 3A, tr = 0.5μs, T <sub>j</sub> = 25°C, tp = 40μs		-	2	V
<b>I<sub>L</sub></b>	Latching current	T <sub>j</sub> = 25°C, V <sub>D</sub> = 5V		-	3	A
<b>I<sub>H</sub></b>	Holding current	T <sub>j</sub> = 25°C, R <sub>G-K</sub> = ∞, I <sub>TM</sub> = 500A, I <sub>T</sub> = 5A		-	300	mA

**GATE TRIGGER CHARACTERISTICS AND RATINGS**

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>GT</sub>	Gate trigger voltage	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25°C	1.5	V
V <sub>GD</sub>	Gate non-trigger voltage	At 50% V <sub>DRM</sub> , T <sub>case</sub> = 125°C	TBD	V
I <sub>GT</sub>	Gate trigger current	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25°C	350	mA
I <sub>GD</sub>	Gate non-trigger current	At 50% V <sub>DRM</sub> , T <sub>case</sub> = 125°C	TBD	mA

**CURVES**

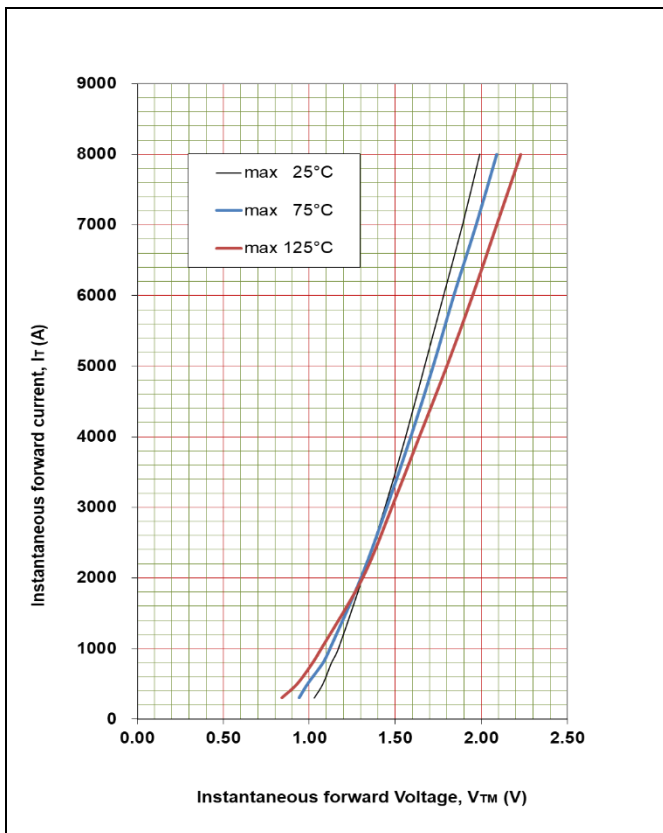


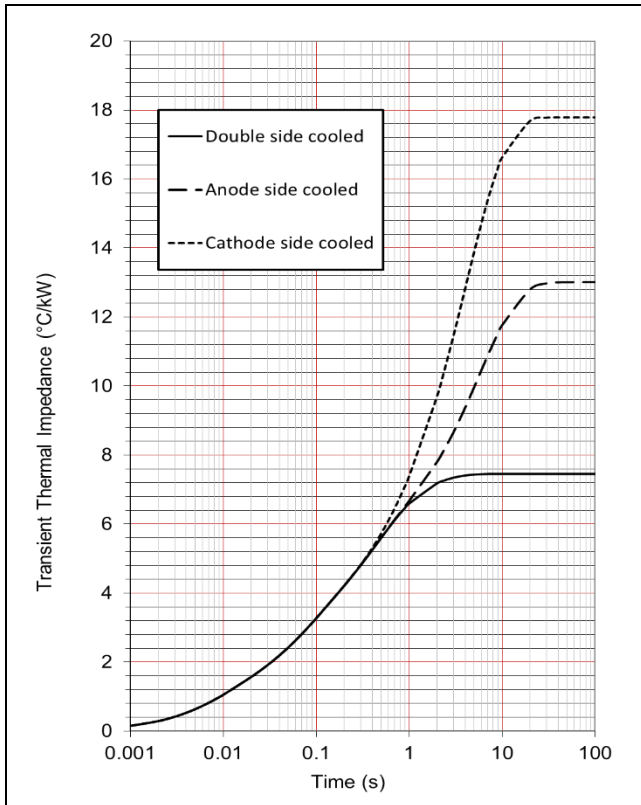
Fig. 2 Maximum on state characteristics

**V<sub>TM</sub> EQUATION**

$$V_{TM} = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

Where A = -0.303672  
 B = 0.216168  
 C = 0.000164  
 D = -0.007999

These values are valid for T<sub>j</sub> = 125°C for I<sub>T</sub> 300A to 8000A



		<b>1</b>	<b>2</b>	<b>3</b>	<b>4</b>
Double side cooled	Ri(°C/kW)	0.9206	1.8299	3.4022	1.3044
	Ti(s)	0.007681	0.05795	0.4079	1.2085
Anode side cooled	Ri(°C/kW)	0.9032	1.6719	3.0101	7.4269
	Ti(s)	0.007587	0.05365	0.3145	5.6240
Cathode side cooled	Ri(°C/kW)	0.9478	2.0661	1.6884	13.0847
	Ti(s)	0.007844	0.06455	0.3894	4.1447

$$Z_{th} = \sum_{i=1}^{i=4} R_i \cdot \left(1 - \exp\left(-\frac{T}{T_i}\right)\right)$$

**ΔR<sub>th(j-c)</sub> Conduction**

Tables show the increments of thermal resistance R<sub>th(j-c)</sub> when the device operates at conduction angles other than d.c.

Double side cooling		
θ°	ΔZ <sub>th</sub> (z)	
	sine.	rect.
180	1.34	0.88
120	1.57	1.30
90	1.83	1.54
60	2.08	1.81
30	2.27	2.11
15	2.36	2.28

Anode Side Cooling		
θ°	ΔZ <sub>th</sub> (z)	
	sine.	rect.
180	1.34	0.88
120	1.57	1.30
90	1.84	1.54
60	2.08	1.81
30	2.28	2.11
15	2.37	2.28

Cathode Sided Cooling		
θ°	ΔZ <sub>th</sub> (z)	
	sine.	rect.
180	1.33	0.88
120	1.57	1.29
90	1.83	1.53
60	2.07	1.80
30	2.26	2.10
15	2.35	2.26

**Fig. 3 Maximum (limit) transient thermal impedance – junction to case (degC/kW)**

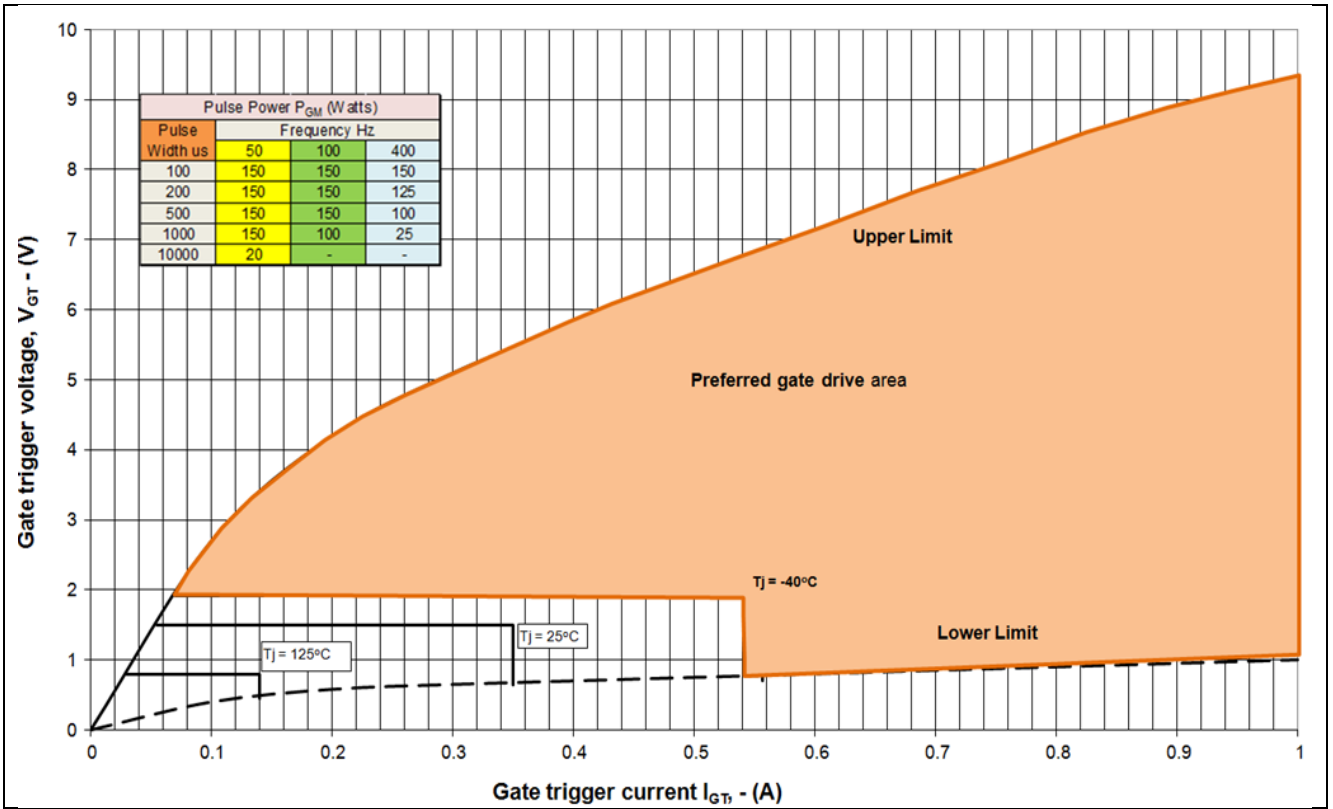


Fig. 4 Gate characteristics

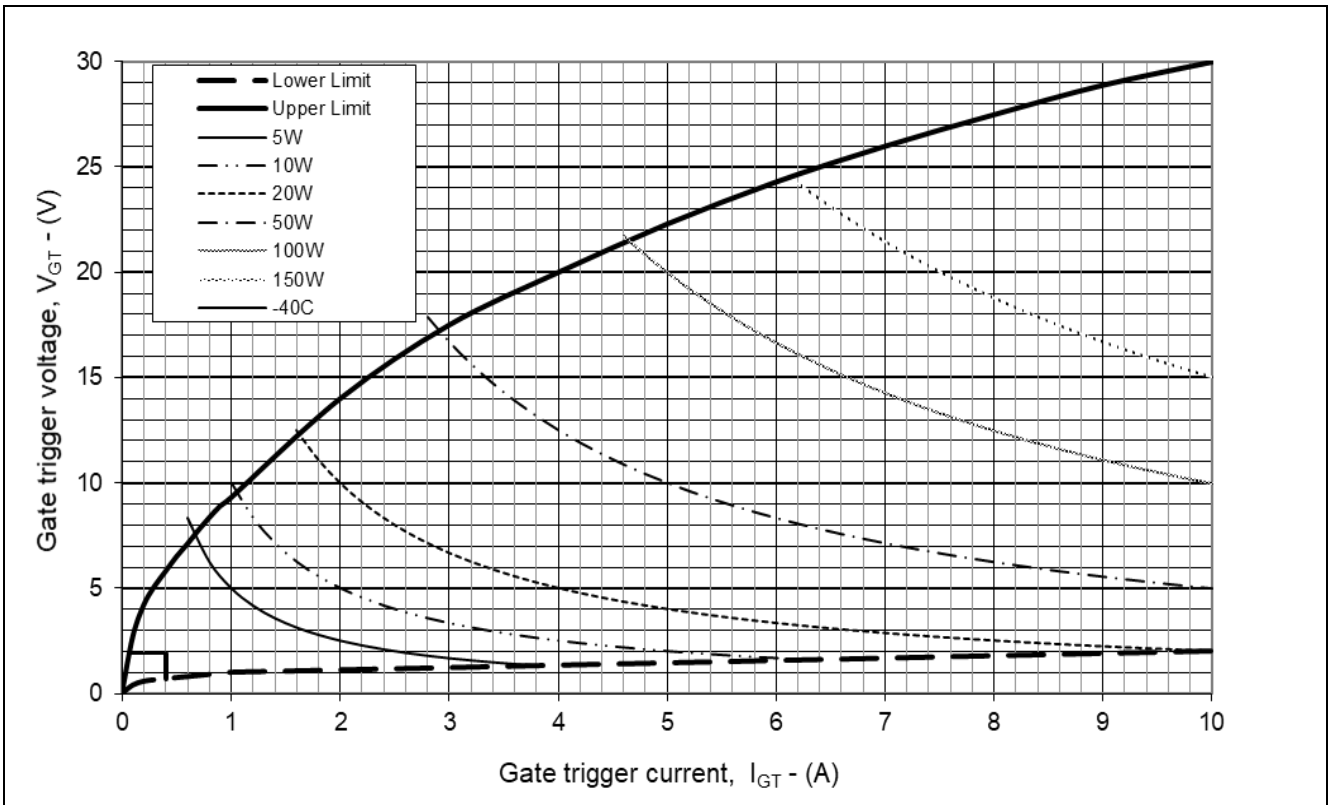


Fig. 5 Gate characteristics

**PACKAGE DETAILS**

For further package information, please contact Customer services.

All dimensions in mm, unless stated otherwise.

DO NOT SCALE

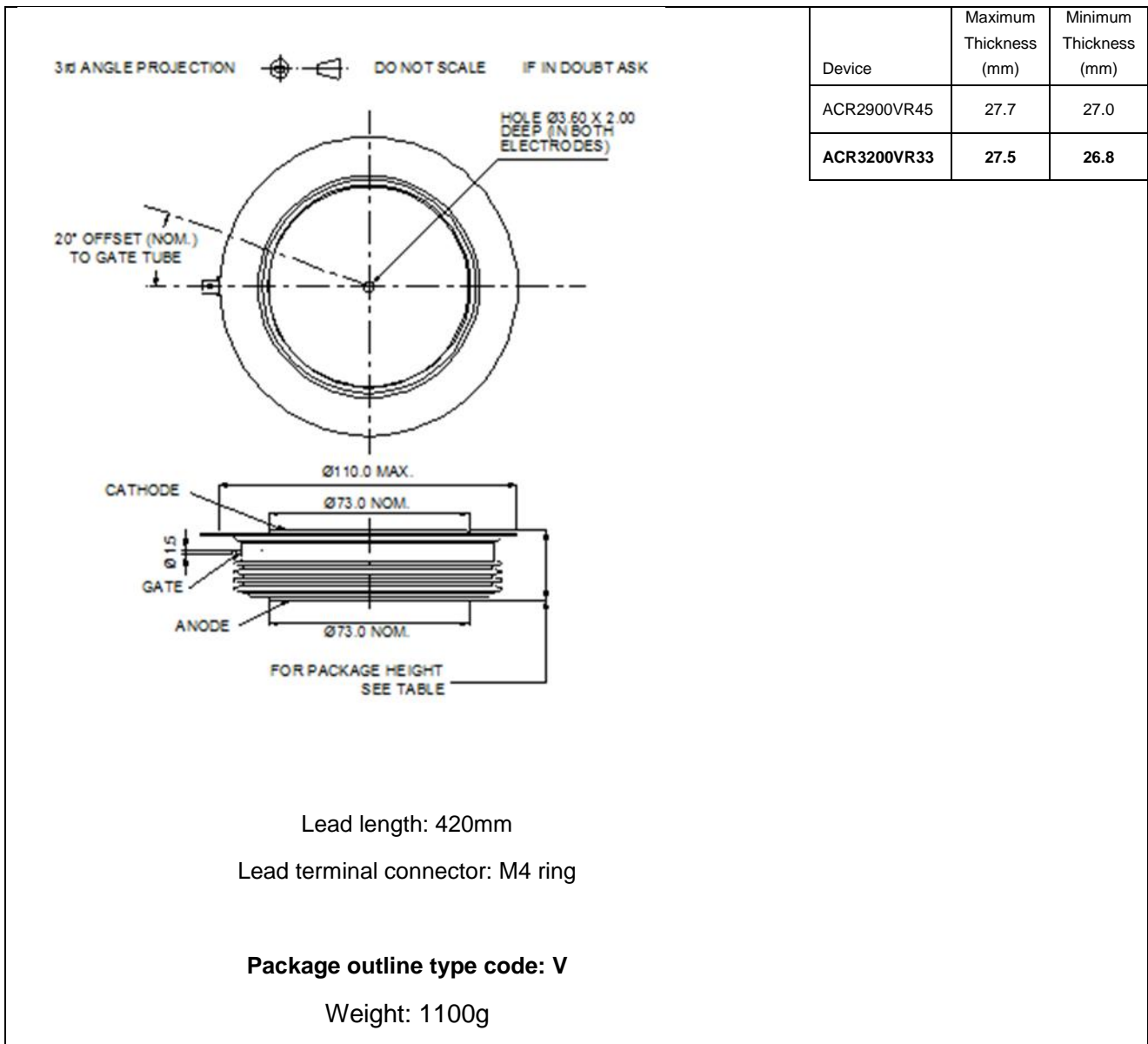


Fig. 6 Package outline

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